



# Analysis of four-port system for bistable memory in silica toroid microcavity



# Wataru Yoshiki & Takasumi Tanabe\*

Department of Electronics and Electrical Engineering, Faculty of Science and Technology, Keio University \*takasumi@elec.keio.ac.jp





# Outline

# □ Background

- Various nonlinearities in an optical microcavity
- Optical bistability in a microcavity
- □ Motivation
- □ Model
  - Two-port and four-port systems
  - Transmittance and coupling
  - CMT and FEM
  - Platform for Kerr bistable memory

# □ Result

- Refractive index change
- Kerr bistable memory in 2-port system
- Kerr bistable memory in 4-port system

# □ Summary





M. Notomi, et al., IET circuits, Devices & Systems 5, 84-93 (2011).



### **Problems**

□ Few demonstrations of bistability using Kerr effect

Nonlinear behavior of side coupled system unknown when Kerr and TO effects are present



#### Purpose of this study

Reveal the nonlinear behavior of a side-couple ring cavity system when the material has Kerr and TO coefficients.





![](_page_7_Figure_0.jpeg)

![](_page_8_Picture_0.jpeg)

![](_page_8_Picture_1.jpeg)

- Platform for Kerr bistable memory -

Model

#### □ Silica toroid microcavity

![](_page_8_Picture_4.jpeg)

- **Has ultra-high quality factor**  $(Q_{int} = 4x10^8 [1])$ .
- Mainly composed of silica.
  - Extremely low material loss ( $\alpha = 0.2 \text{ dB/m}$ ).
  - No carrier generation (no carrier effect).
- Can be fabricated on a chip.

#### Choose as a platform of Kerr bistable memory

#### □ Parameters & assumptions used for calculation

- $\tau_{\text{int}} = 329 \text{ ns}$  (corresponding to  $Q_{\text{int}} = 4 \times 10^8$ ).
- Intrinsic loss is dominated by the absorption ( $\tau_{int} \approx \tau_{abs}$ ).
- Critical coupling condition  $\tau_{coup1} = (\tau_{int}^{-1} + \tau_{coup2}^{-1})^{-1}$  is satisfied.

[1] T. Kippenberg, et al., Appl. Phys. Lett. 85, 6113-6115 (2004).

#### 田邉フォトニック構造研究室

Tanabe Photonic Structure Laboratory

![](_page_9_Picture_2.jpeg)

# Result

- Refractive index change dependent on  $au_{
m coup2}$ -

![](_page_9_Figure_5.jpeg)

**Refractive index change caused by** Kerr and TO effects in 4-port system.

- $\square$  3 µs-wide rectangular pulse inputted.
  - Only the regime, where  $\Delta n_{\text{Kerr}}$  is flat and  $\Delta n_{\text{Kerr}}$ is larger than  $\Delta n_{\rm TO}$ , can be used for Kerr bistable memory.

(shown as "Kerr memory usable")

 $\Delta n_{\text{Kerr}}$  is larger than  $\Delta n_{\text{TO}}$  until 2.3 µs is passed. **Rising time of**  $\Delta n_{\text{Kerr}}$  become shorter when  $\tau_{\rm coup2}$  become shorter.

#### Short- $\tau_{coup}$ is desirable for the effective use of "Kerr memory usable" regime.

![](_page_10_Figure_0.jpeg)

- However,  $P_{out}$  doesn't show the bistability.
- Kerr bistable memory is **not** feasible in a 2-port system.

![](_page_11_Figure_0.jpeg)

- Kerr bistable memory is feasible in a 4-port system.
  - Memory holding time: 500 ns
  - Drive power: 7.3 mW

2012/12/04 ISPEC2012 W. Yoshiki 12

![](_page_12_Picture_0.jpeg)

# Described the behavior of a side-couple and a 4-port WGM cavity systems by using CMT and FEM.

Reveled that optical Kerr bistable memory is feasible in a 4-port system (but it is difficult with a 2-port system) when TO effect is present

![](_page_13_Picture_0.jpeg)

![](_page_13_Picture_1.jpeg)

# Thank you for your attention!

#### For more information

W. Yoshiki and T. Tanabe, "Analysis of bistable memory in silica toroid microcavity," J. Opt. Soc. Amer. B **29**, 3335-3343 (2012).

# Acknowledgement

![](_page_13_Picture_6.jpeg)

Strategic Information and Communications R&D Promotion Programme (SCOPE), from the Ministry of Internal Affairs and Communications

Canon The Canon Foundation